Application/Control No. Applicant(s)/Patent Under Reexamination 09/998,776 LATINO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1764 Hien Tran **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY 08-1980 Schock et al. 422/171 US-4,218,422 Α В US-С US-D US-Ε US-US-F US-G US-Н US-1 J US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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